

# ***Short-Pulse Dense Wavelength-Division-Multiplexed Optical Interconnects***

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**<http://ee.stanford.edu/~dabm>**



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# Summary

## WDM interconnects between silicon chips

- short-pulse WDM
- dense receiver/transmitter arrays

## Synchronization with short pulses

- data resynchronization
  - *skew and jitter removal*

## Ultrafast optoelectronic gate

- possible time-division demultiplexing and wavelength conversion component,
  - *controllable by electronics*

## GaInAsN for high uniformity long-wavelength devices

- unity sticking coefficient of N should allow high uniformity devices for long wavelengths
- potentially usable in long wavelength WDM systems

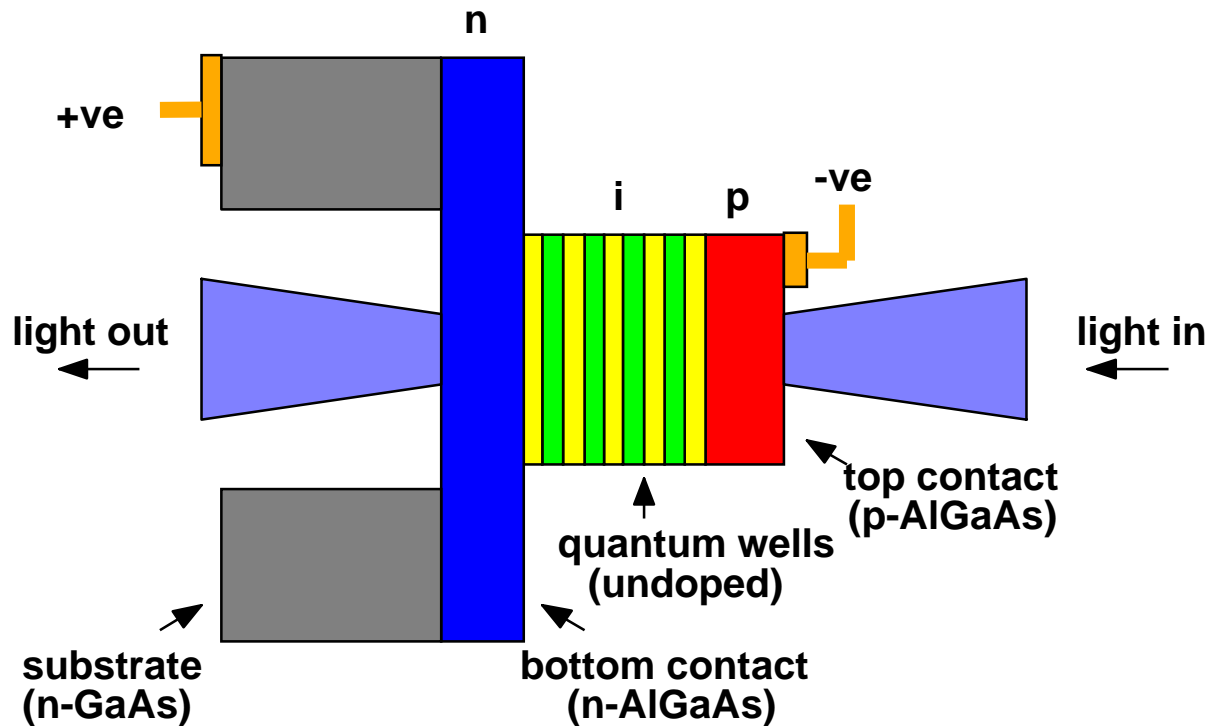
# ***Modulator-Based Interconnects***

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## **quantum well reflective modulators**

- solder bonded to silicon integrated circuits
- can function either as photodetector or output modulator (depending on circuit)
- can be made successfully in large numbers
- can be used with short pulse sources
- can be used with WDM sources (usable range ~ 6 - 10 nm)

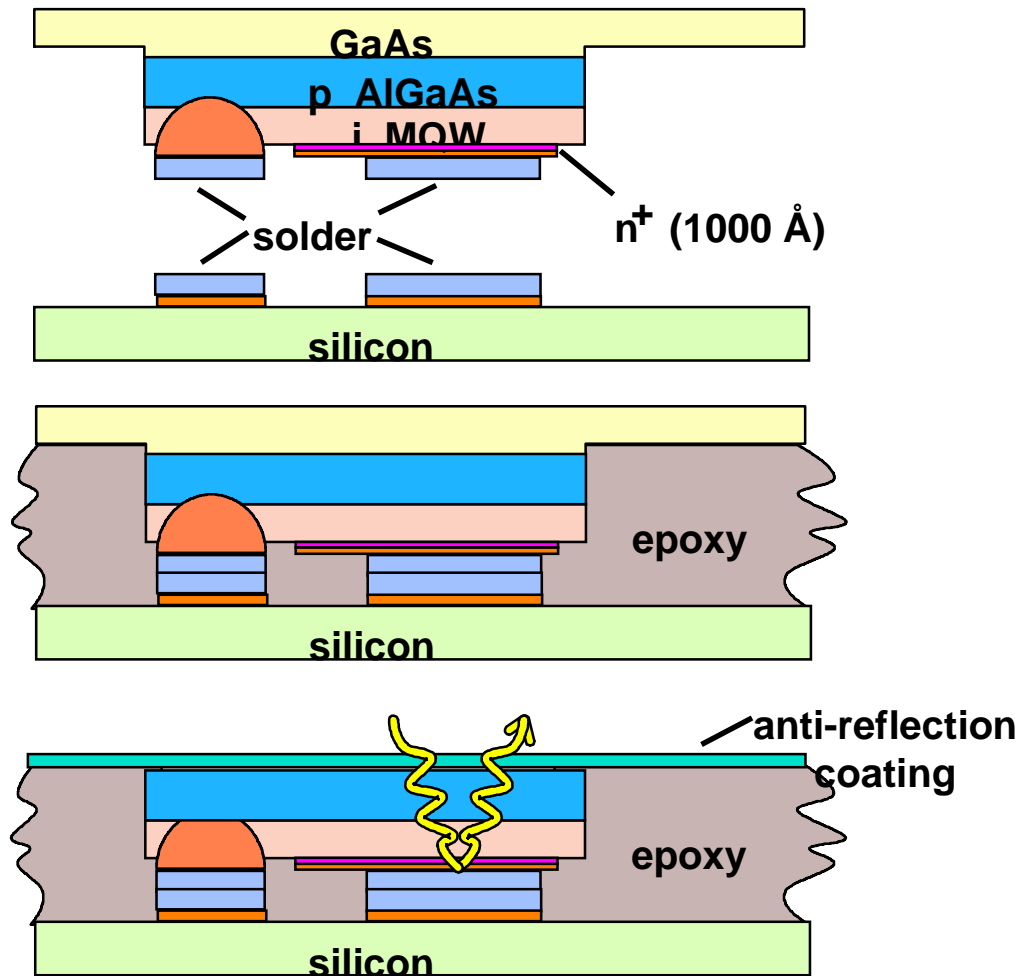
# Quantum Well Modulator



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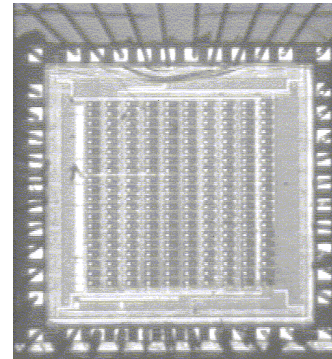
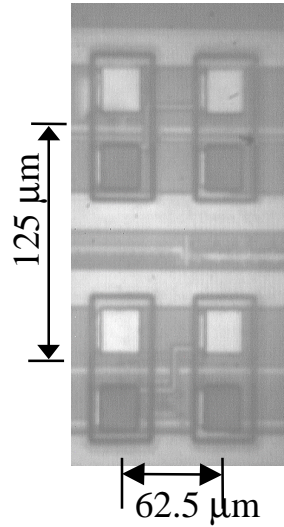
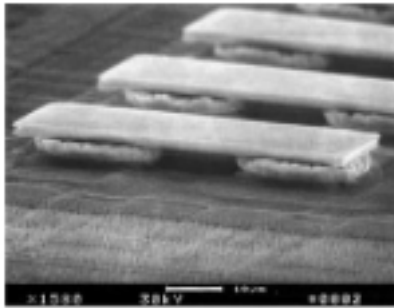
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# Quantum Well Modulators Solder-Bonded to Silicon Circuits - Hybrid SEED (Self Electro-optic Effect Device)

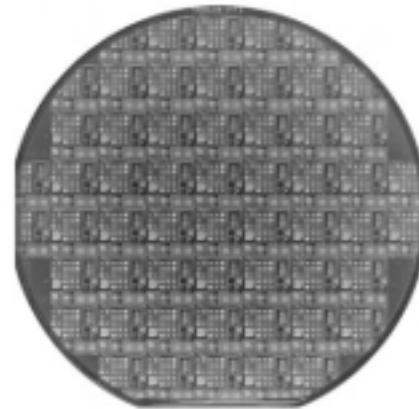
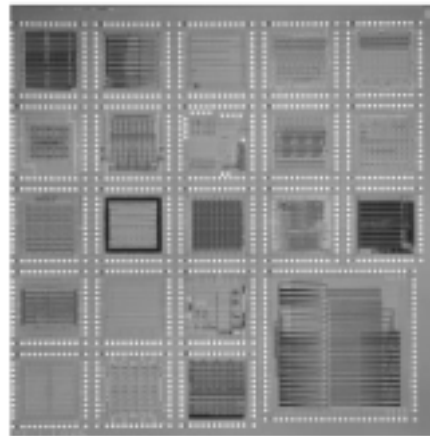
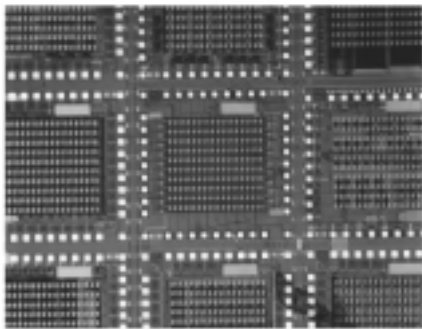


K. W. Goossen et al.,  
IEEE Photonics Tech.  
Lett. 7, 360 - 362  
(1995)

# *Bell Labs Multiproject OE-VLSI Wafer*



Arrays of solder-bonded multiple quantum well modulator/detector diodes on 0.5  $\mu\text{m}$  Si CMOS

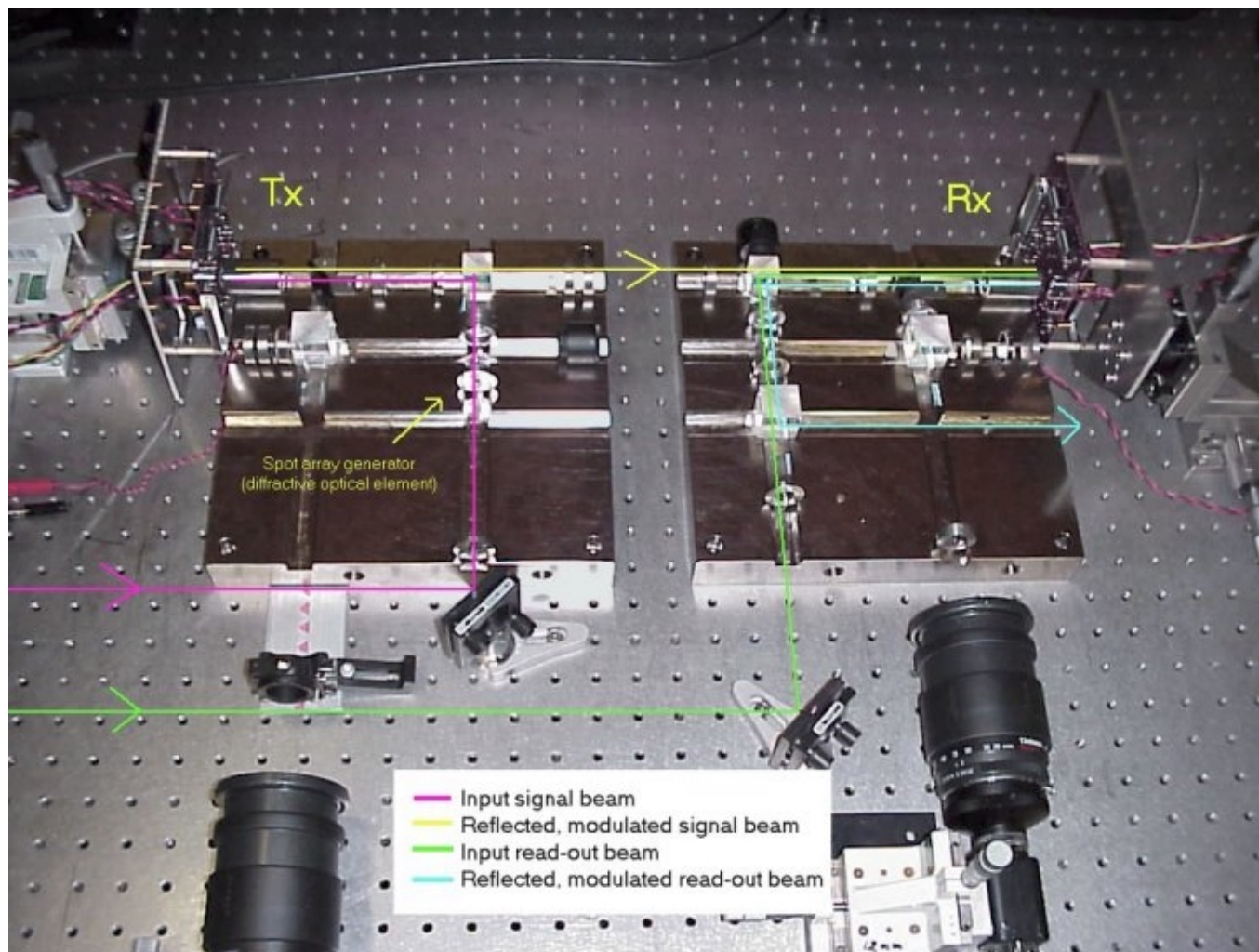


**A. V. Krishnamoorthy and K. W. Goossen, IEEE J. Sel. Top. Quantum Electronics 4, 899 (1998)**

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# ***Baseplate Testing Setup***

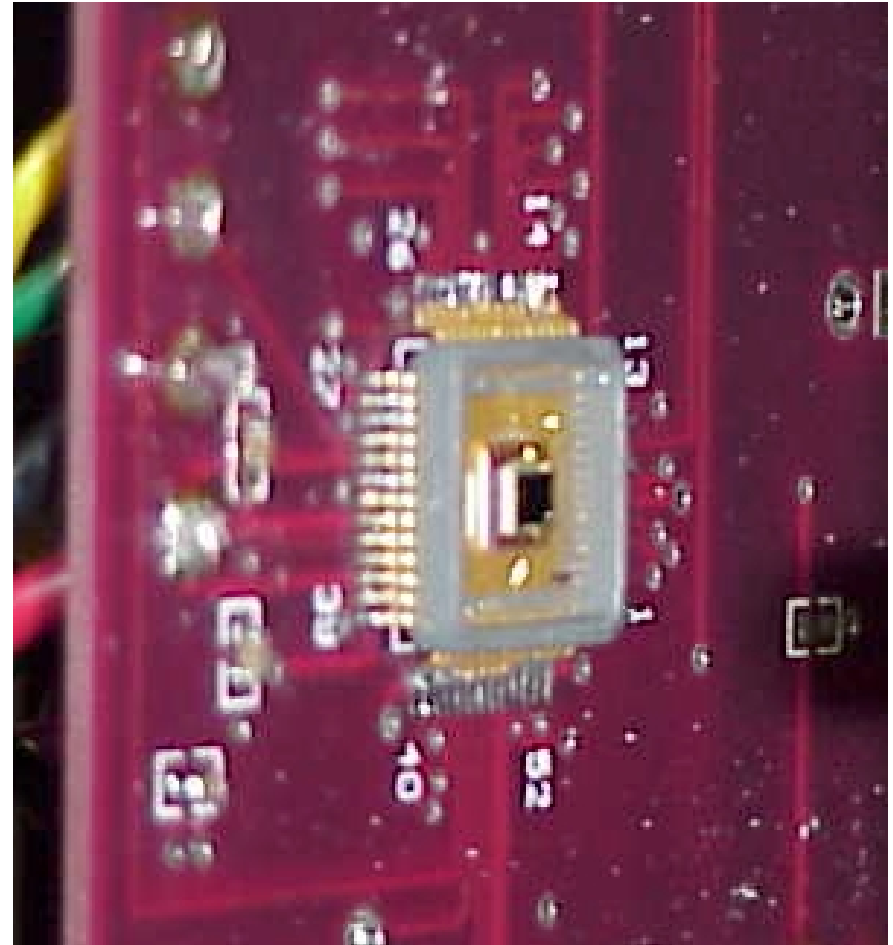
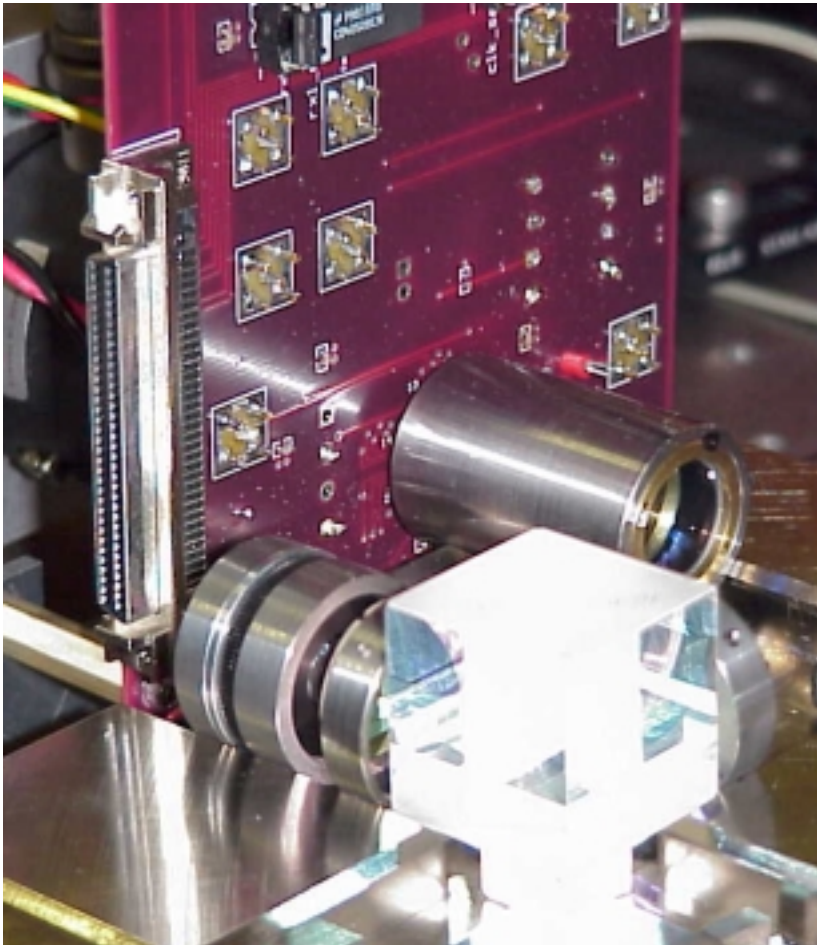


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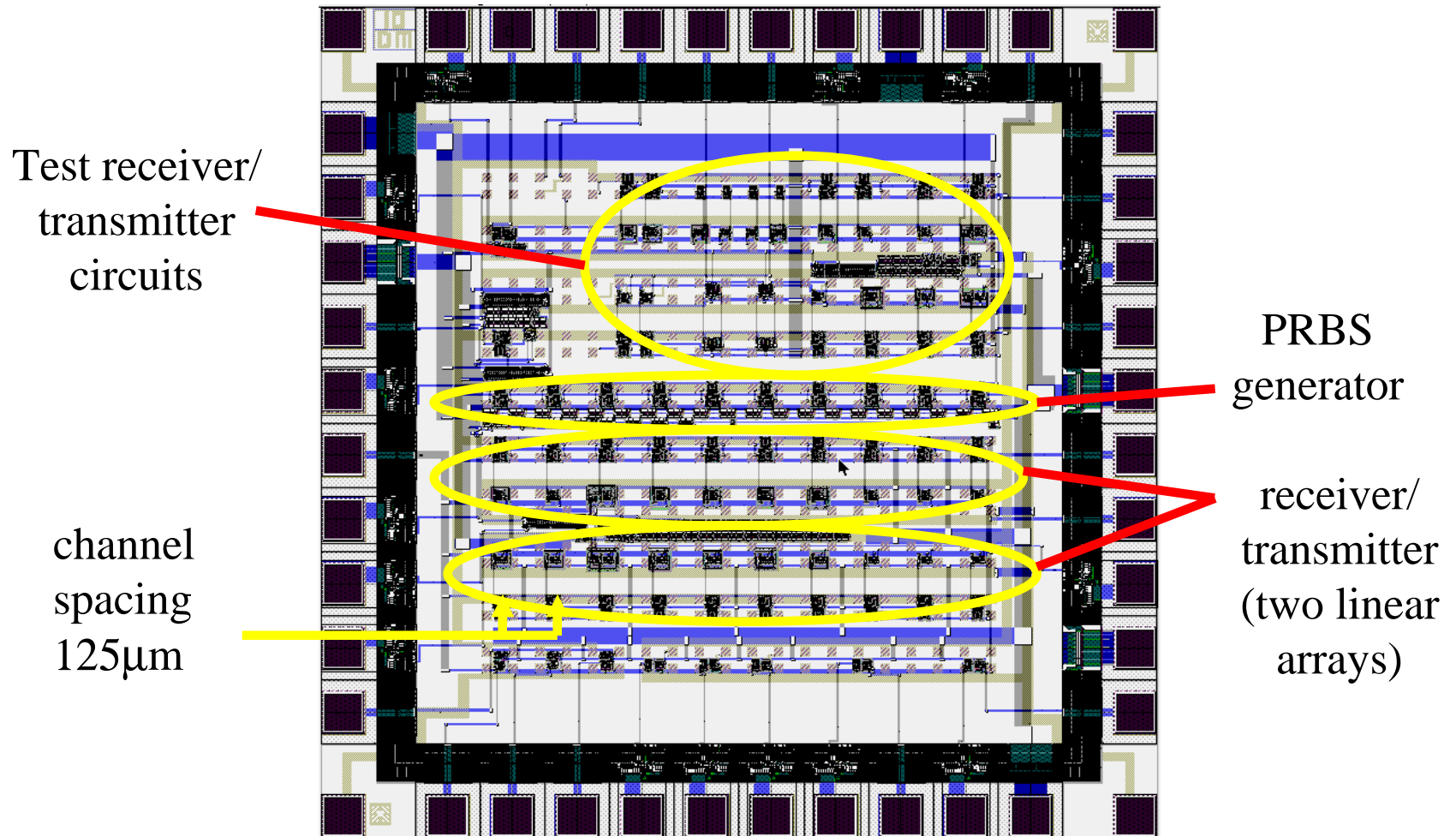
## *Close-up of Transmitter*



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# Chip Details



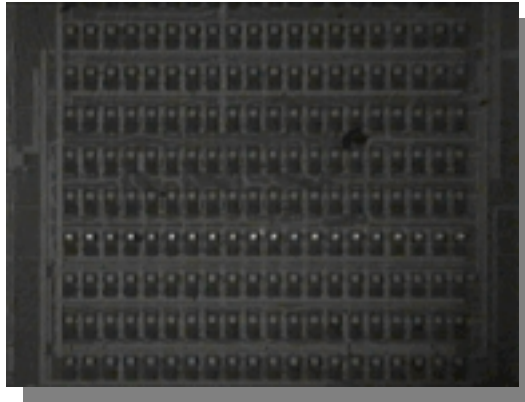
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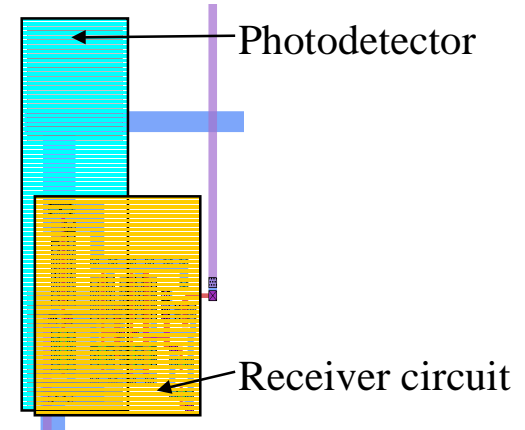
# Example linear array optical interconnect

## Transmitter chip

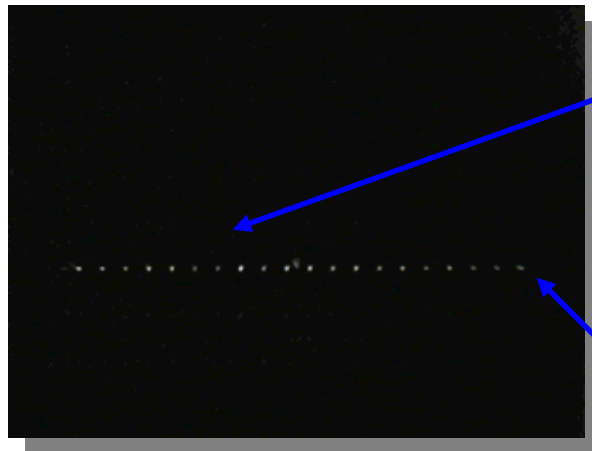
Modulator array operating with readout beams from spot array generator



## Receiver layout

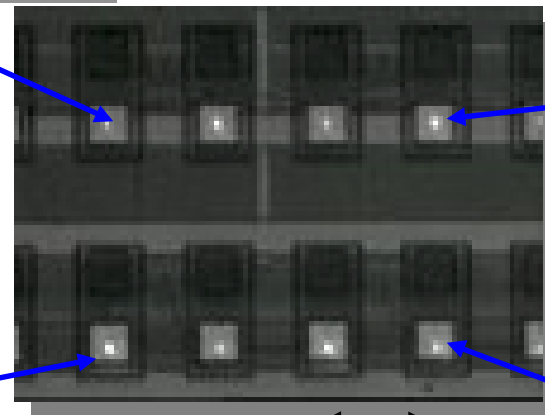


## Receiver chip



Test optical readout from modulators connected to receiver circuit outputs

Modulated optical inputs from transmitter chip

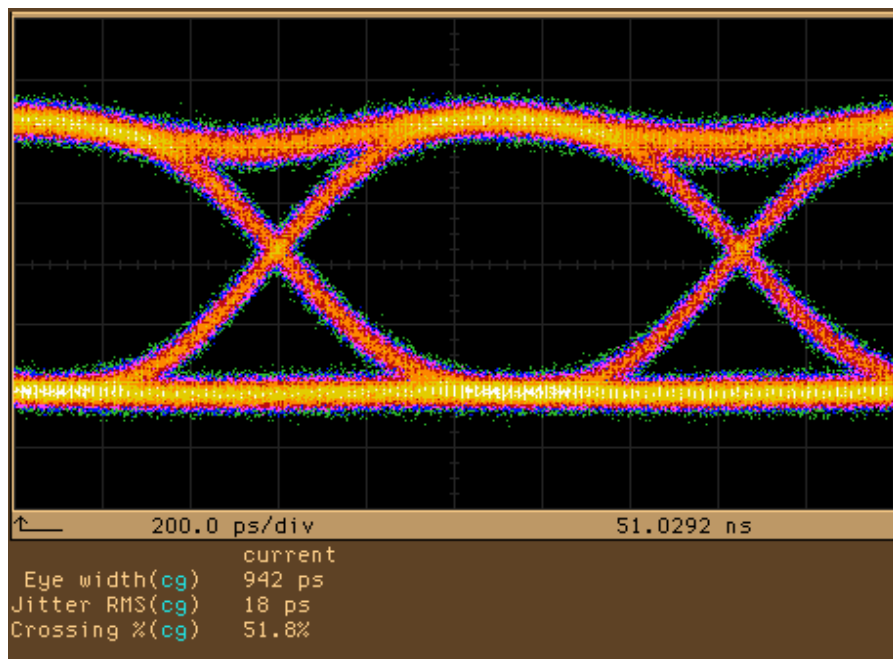


Receiver array with

- test output modulators
- receiver circuits (obscured by photodetectors)
- photodetectors

62.5  $\mu\text{m}$

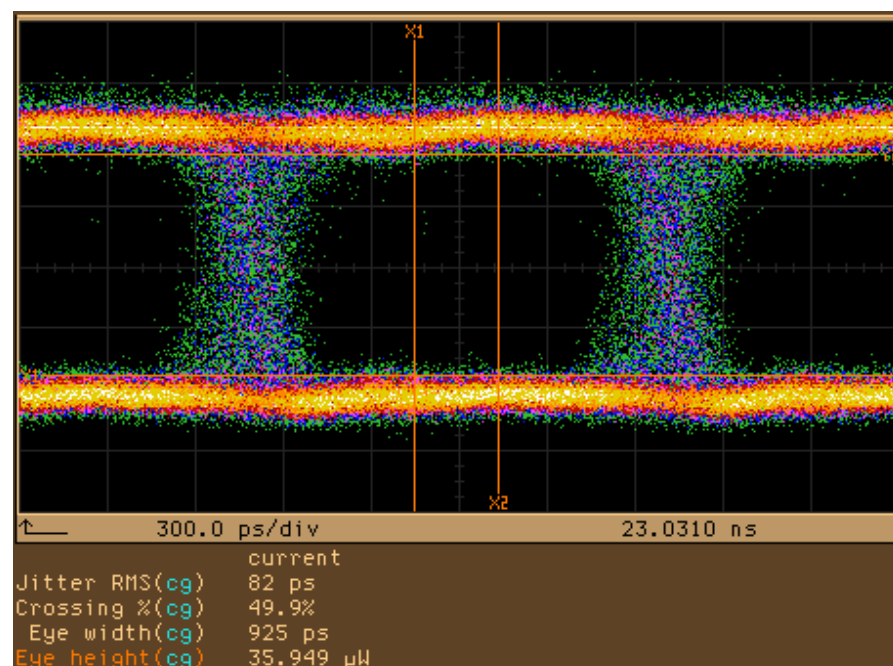
# Device performance



950 Mb/s modulator  
output with cw readout

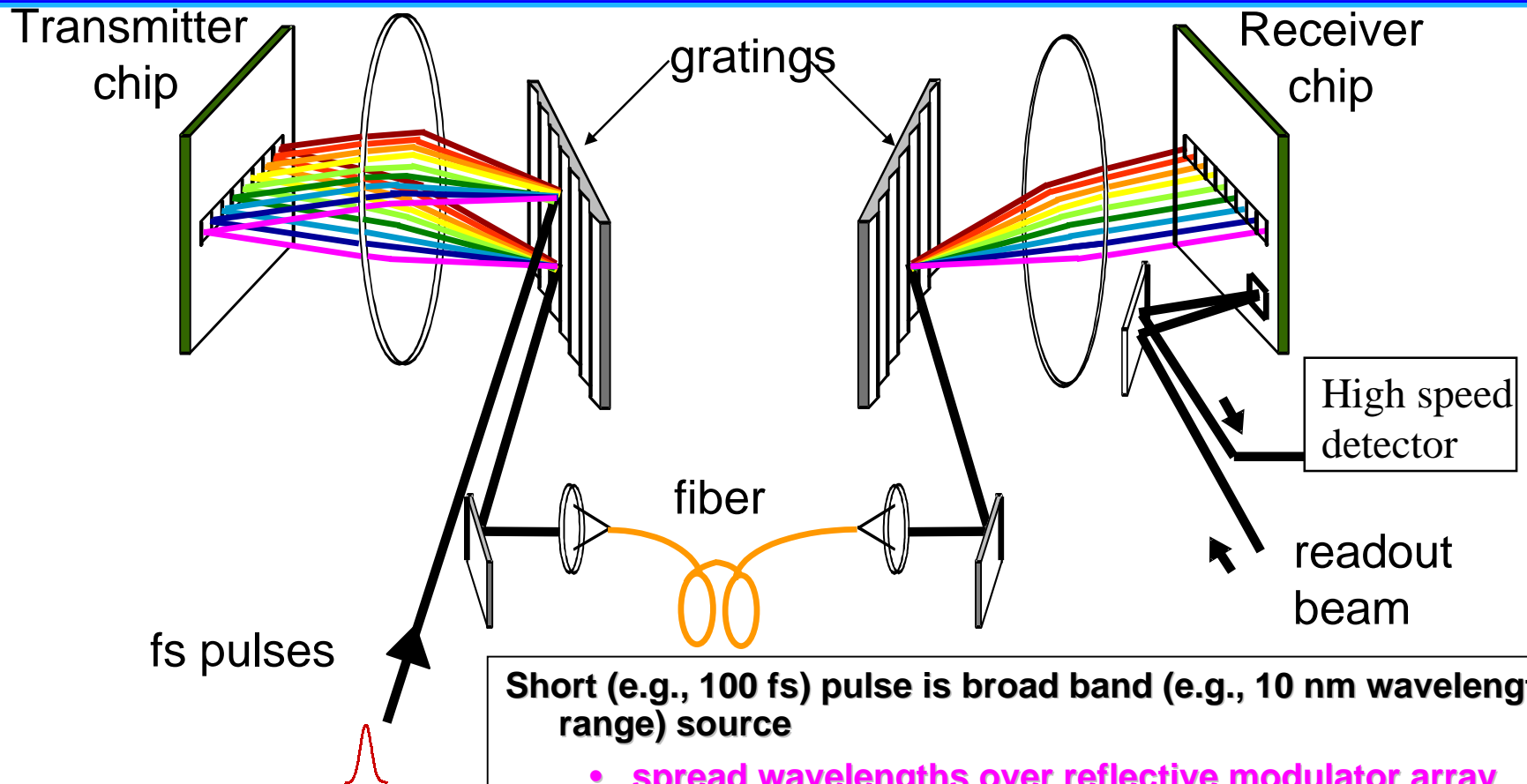


700 Mb/s receiver eye diagram  
using cw laser drive (100  $\mu$ W  
optical power per diode)



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# Short Pulse WDM Interconnect System



Short (e.g., 100 fs) pulse is broad band (e.g., 10 nm wavelength range) source

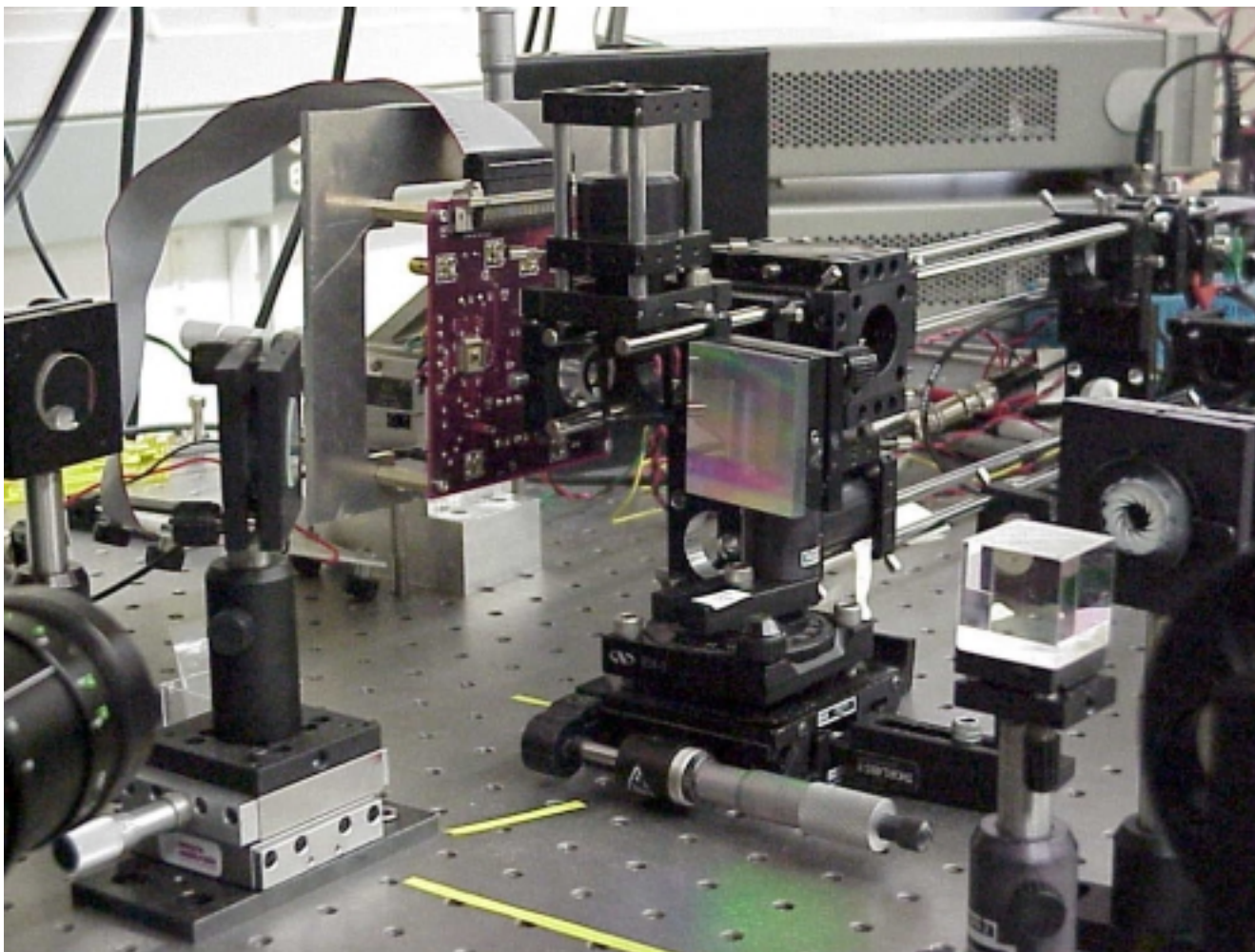
- spread wavelengths over reflective modulator array
- send reflected signals over single fiber to receiver array

***Multiple channel interconnect with single fiber and single laser***

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# ***WDM Interconnect Setup***

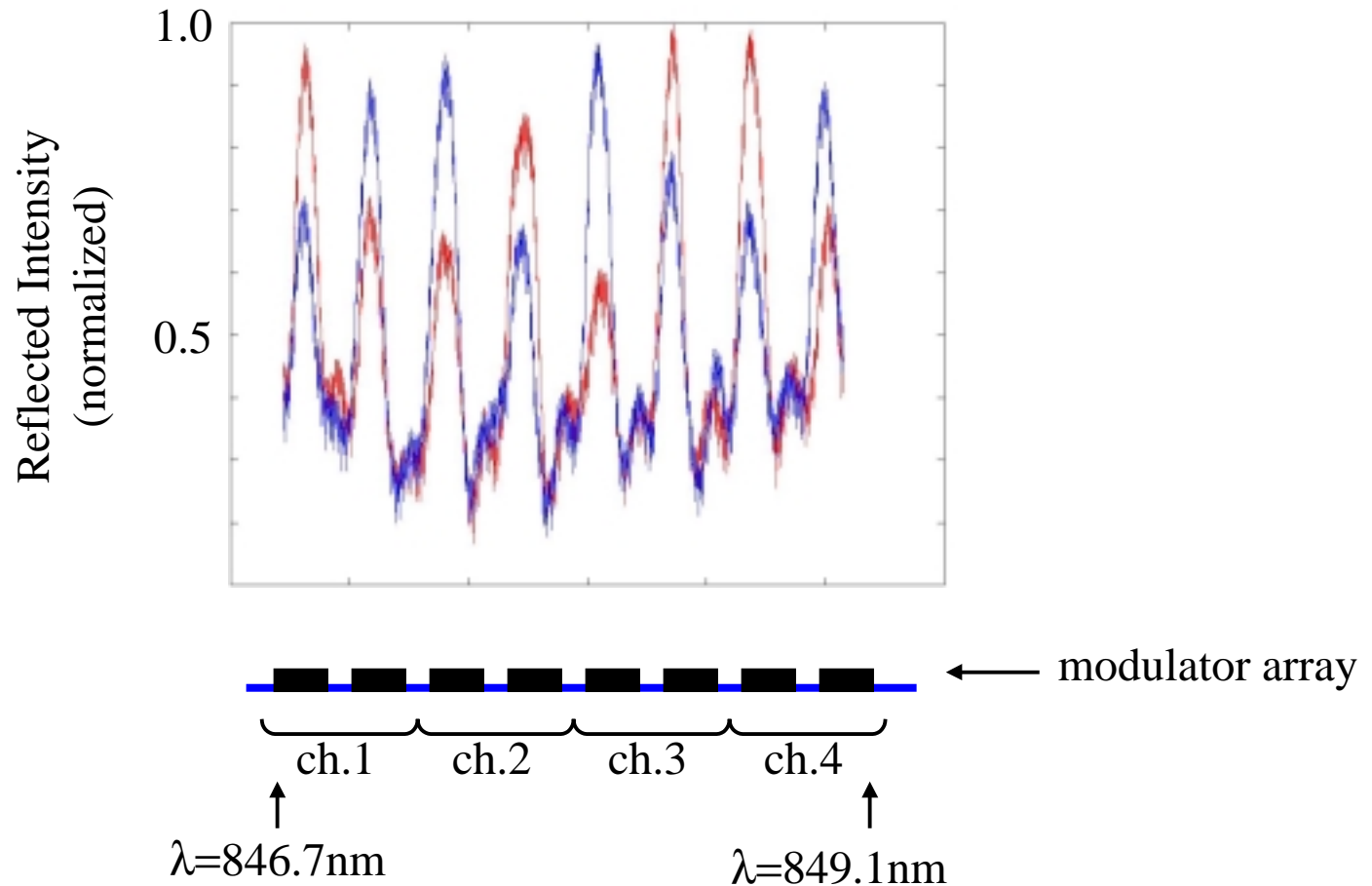


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# Modulator Array Testing

Modulator array output in Optical Spectrum Analyzer System

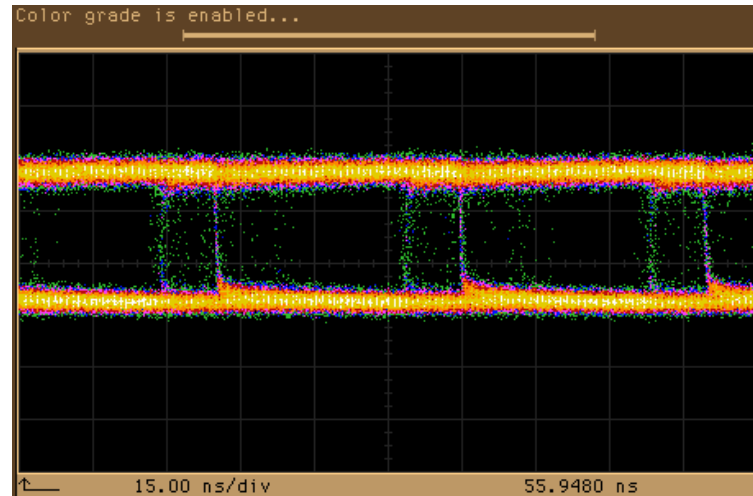


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# Operation of WDM Interconnect



Receiver eye with optical readout

**Entire WDM interconnect system operating at 20 Mbps**

**Key issues limiting system performance**

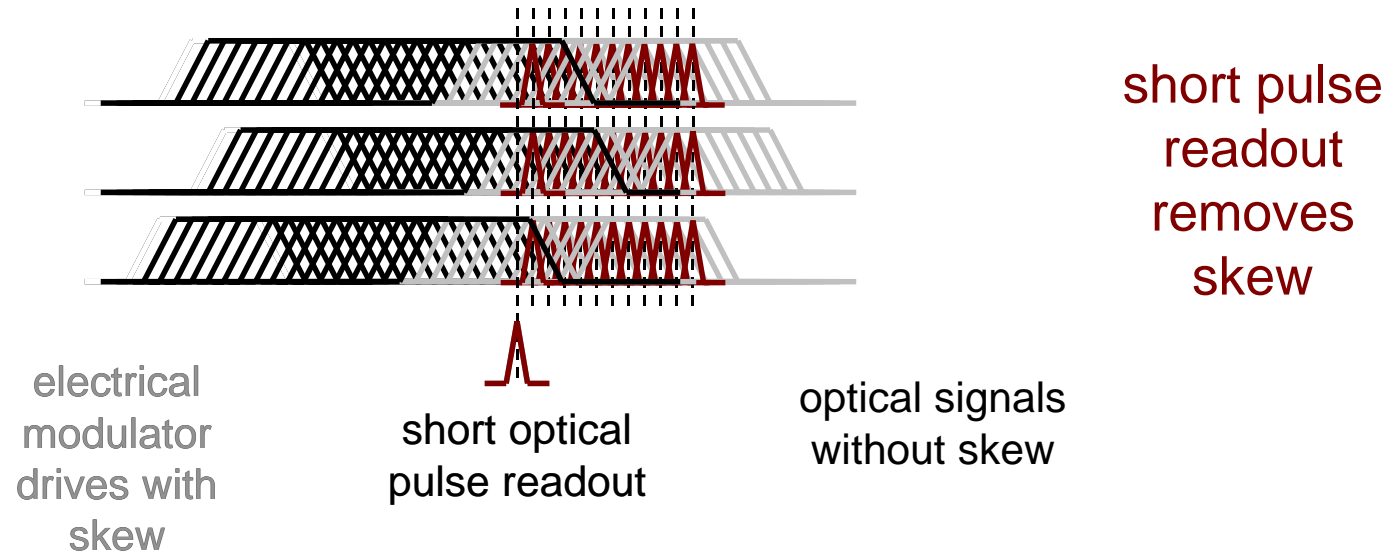
- **insufficient uniformity in silicon receiver circuits**
  - *improved circuits now in fabrication*
- **simple bench-top optomechanics not sufficiently rigid**
  - *second generation optomechanics now under construction*

# ***Features of short-pulse dense WDM interconnects to silicon chips***

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- avoids electronic multiplexing and demultiplexing
- uses single laser for multiple channels
- uses single fiber for multiple channels
- intrinsically synchronizes all channels
- exploits all other advantages of short pulse interconnects

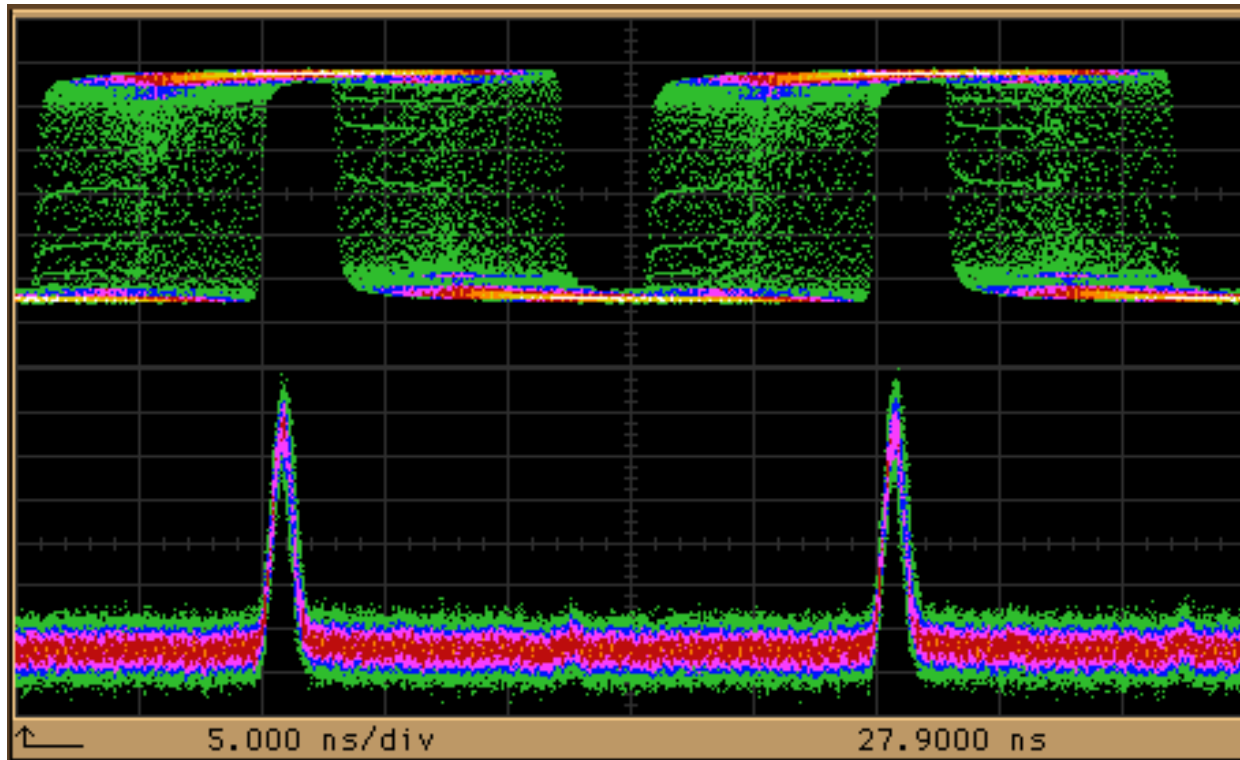
# Removal of Skew By Using Short Pulses With Modulators



**Effectively sampling the data on modulator**

**Up to one half bit of skew in modulator drive can be removed**

# *Experimental Demonstration of Jitter Removal with Short Pulses*



Electrical input  
signal to modulator,  
with jitter

Optical output signal  
after reading out  
with a short pulse,  
receiving the signal,  
and driving a  
second modulator

D. Agarwal, G. Keeler, B. Nelson, D. A. B. Miller (Stanford)

**Demonstration of jitter removal from a single  
interconnect channel, at a clock rate of 82 MHz.**

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# ***GaInAsN for Long-Wavelength Uniform Devices***

**Growth of this material by MBE shows**

- **unity sticking coefficient of nitrogen**
  - *every nitrogen atom that lands on the surface incorporates, independent of growth rate*

**contrasts with strong dependencies of InGaAsP growth on temperature and flux**

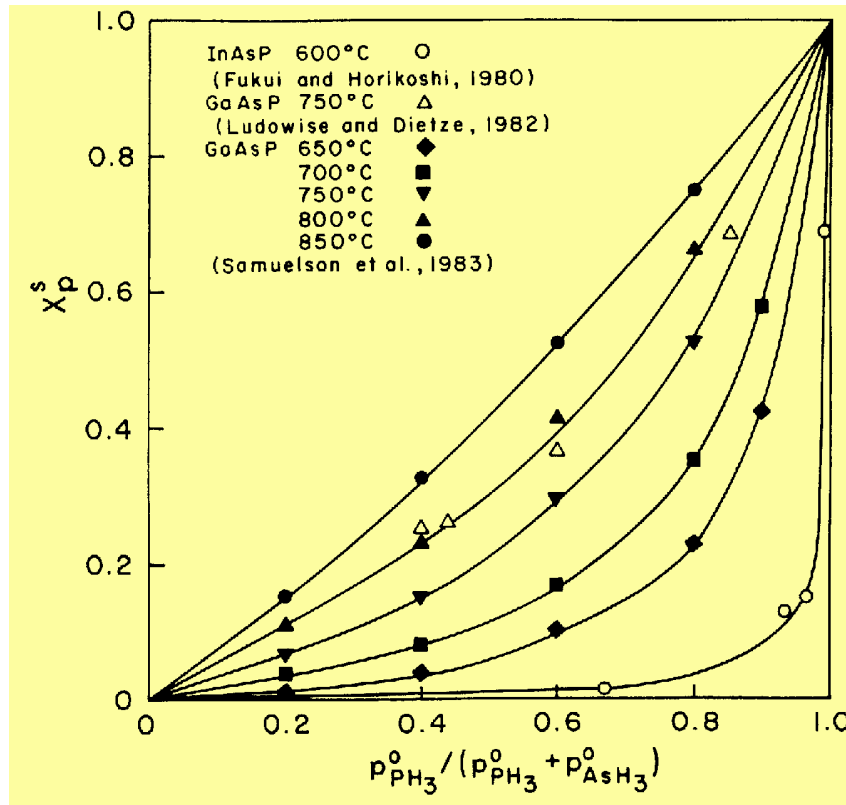
- **may allow uniform, reproducible growth of long-wavelength devices**

**Allows use of GaAs substrates**

**Demonstrated 1.2 micron CW VCSEL**

**Possibilities for other, longer wavelength devices**

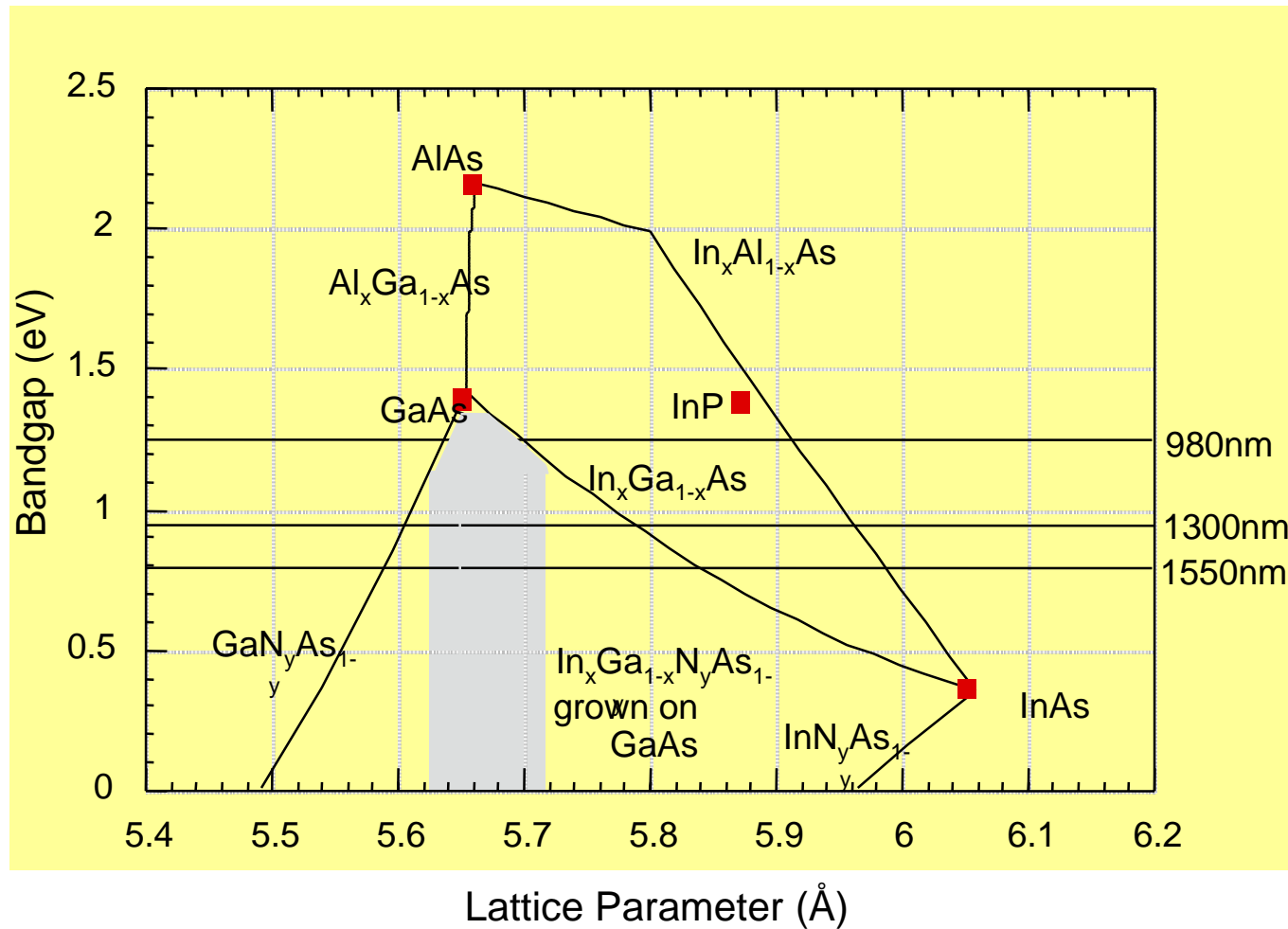
# Group V concentration in Arsenide-Phosphides



Stringfellow  
Organometallic Vapor-phase Epitaxy  
Theory and Practice

Phosphorus concentration ( $x_P^S$ ): dependent on temperature, dependent on  $AsH_3$  and  $PH_3$  flux because both kinetics (incomplete pyrolysis of the hydrides) and thermodynamics determine concentration.

# Bandgaps of III-V Alloys



N causes bandgap of GaAs to decrease rapidly.

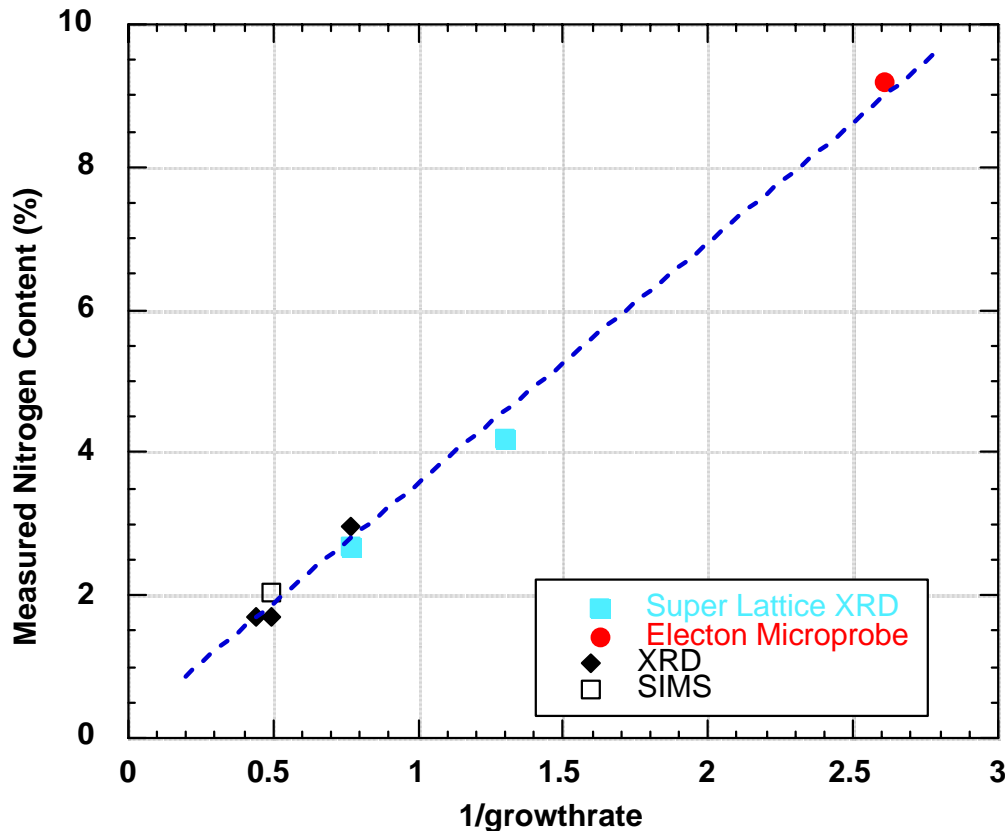
N is small and In is big  $\Rightarrow$  strain can be tuned from tensile to compressive when grown on GaAs.

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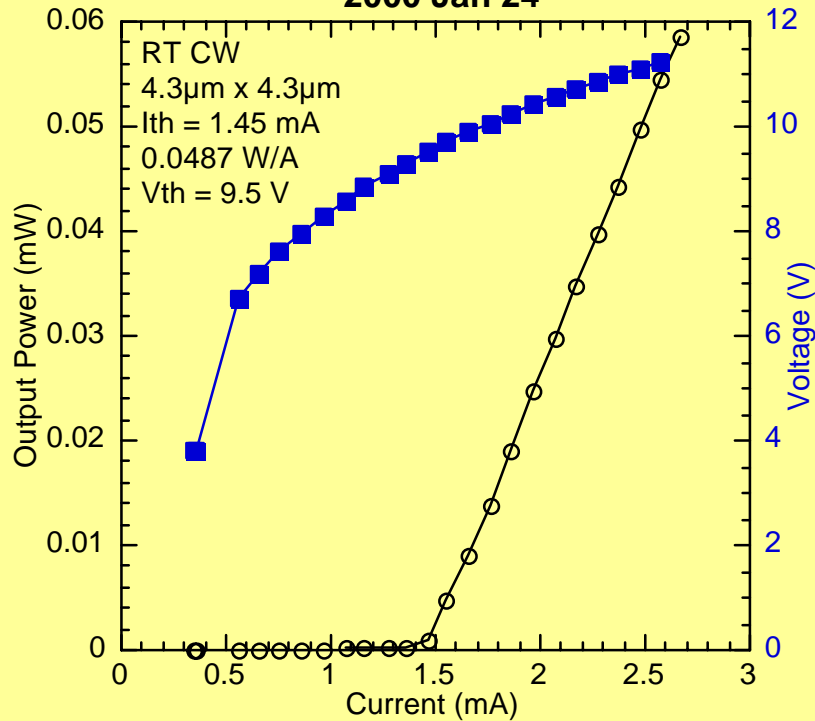
# *GalnNAs Elemental Source MBE*



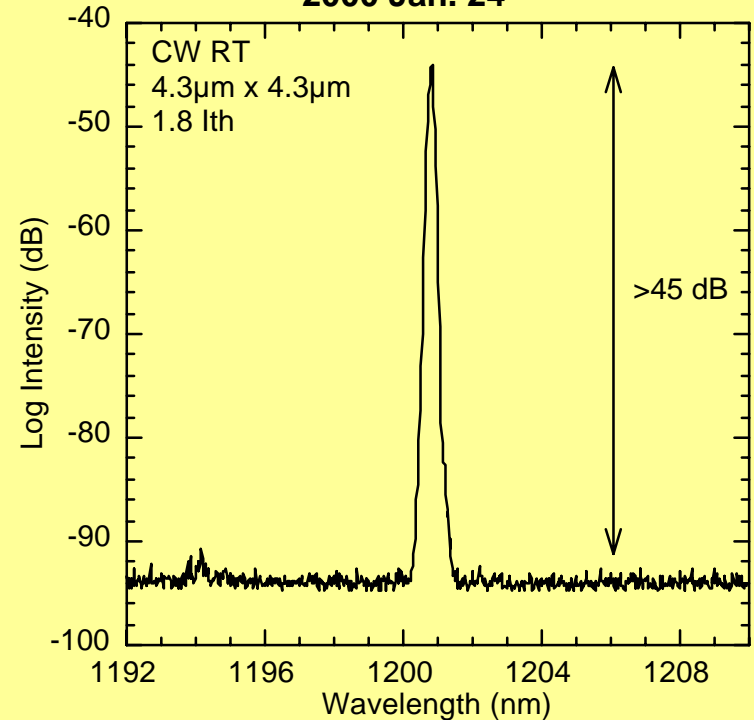
- Low substrate temperature avoids phase segregation
- Atomic Nitrogen sticking coefficient  $\sim 1$  (N mole fraction =  $1/\text{growth rate}$ )
- Hence expect uniform, predicable growth of this material

# CW operation oxide-confined VCSEL

**GalNAs oxide-confined VCSEL 0.1,0#1 CW LIV**  
2000 Jan 24



**GalNAs oxide-confined VCSEL Spectrum**  
2000 Jan. 24



# Ultrafast Optoelectronic Gate

## Device concept

trigger top diode to give rise to temporary local voltage change in bottom diode

voltage change in bottom diode gives temporary change in absorption, modulating beam

Optically-controlled optical gate to transfer data from one beam to another (e.g., different wavelengths)

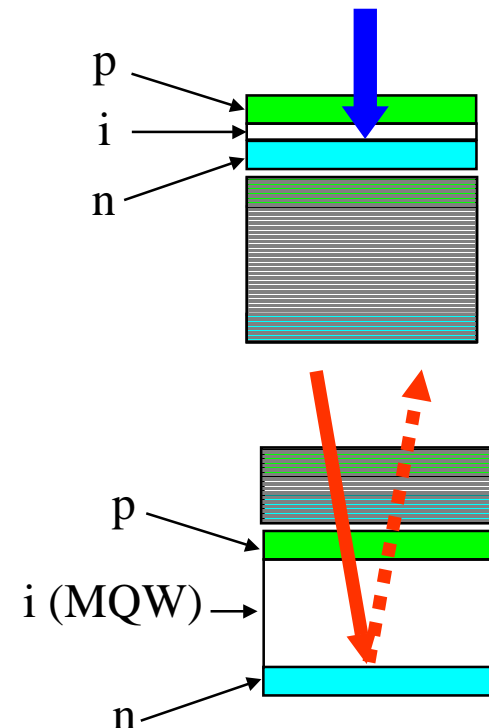
Electrically controlled - only works when diodes are biased

## Top Diode

- Thin intrinsic region
- $\text{Al}_{0.3}\text{Ga}_{0.7}\text{As}$ , transparent at ~850nm

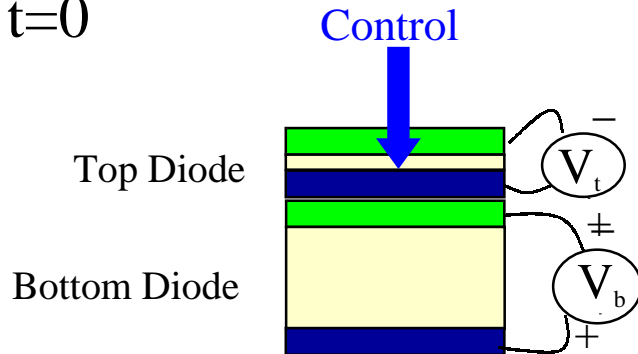
## Bottom Diode

- Thick intrinsic region
- GaAs multiple quantum wells voltage-sensitive at ~850nm



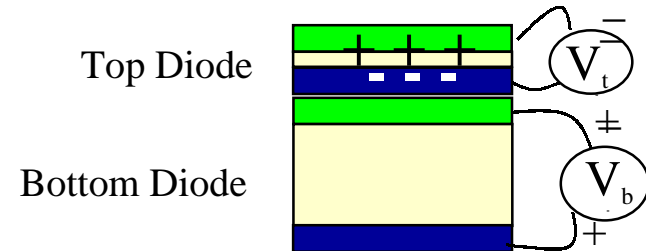
# Basic Design Concept

(1)  $t=0$



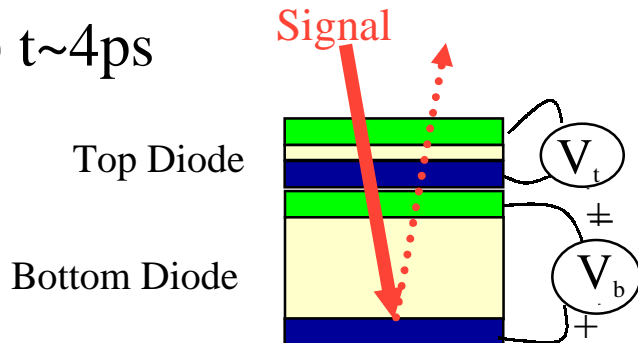
*Control pulse is absorbed in top diode*

(2)  $t=0-4\text{ps}$



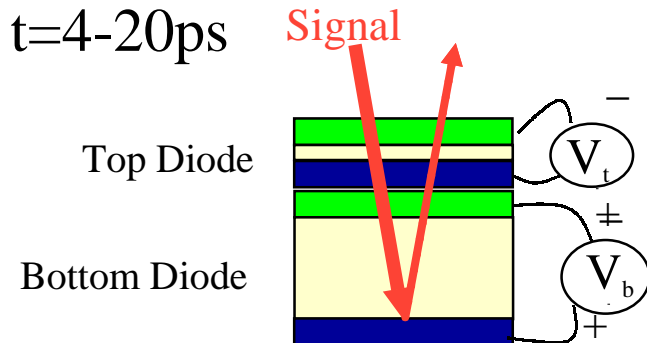
*Due to separation of photogenerated carriers, voltage builds up, shielding the bias*

(3)  $t\sim 4\text{ps}$



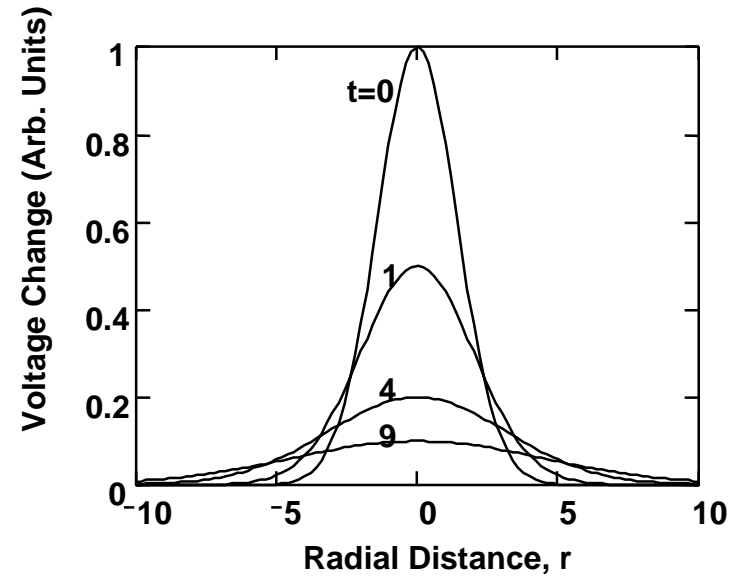
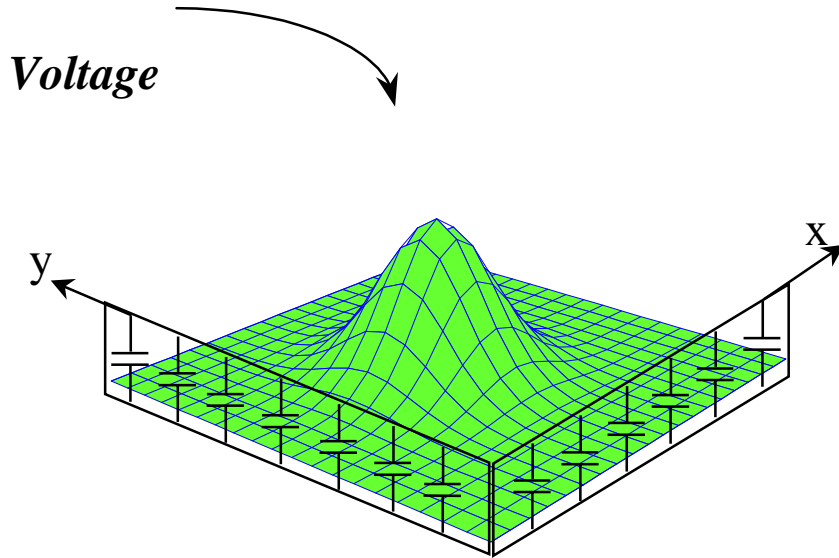
*Voltage build-up changes absorption level in bottom diode: ON*

(4)  $t=4-20\text{ps}$



*Voltage build-up decays away: OFF*

# Diffusive Conduction



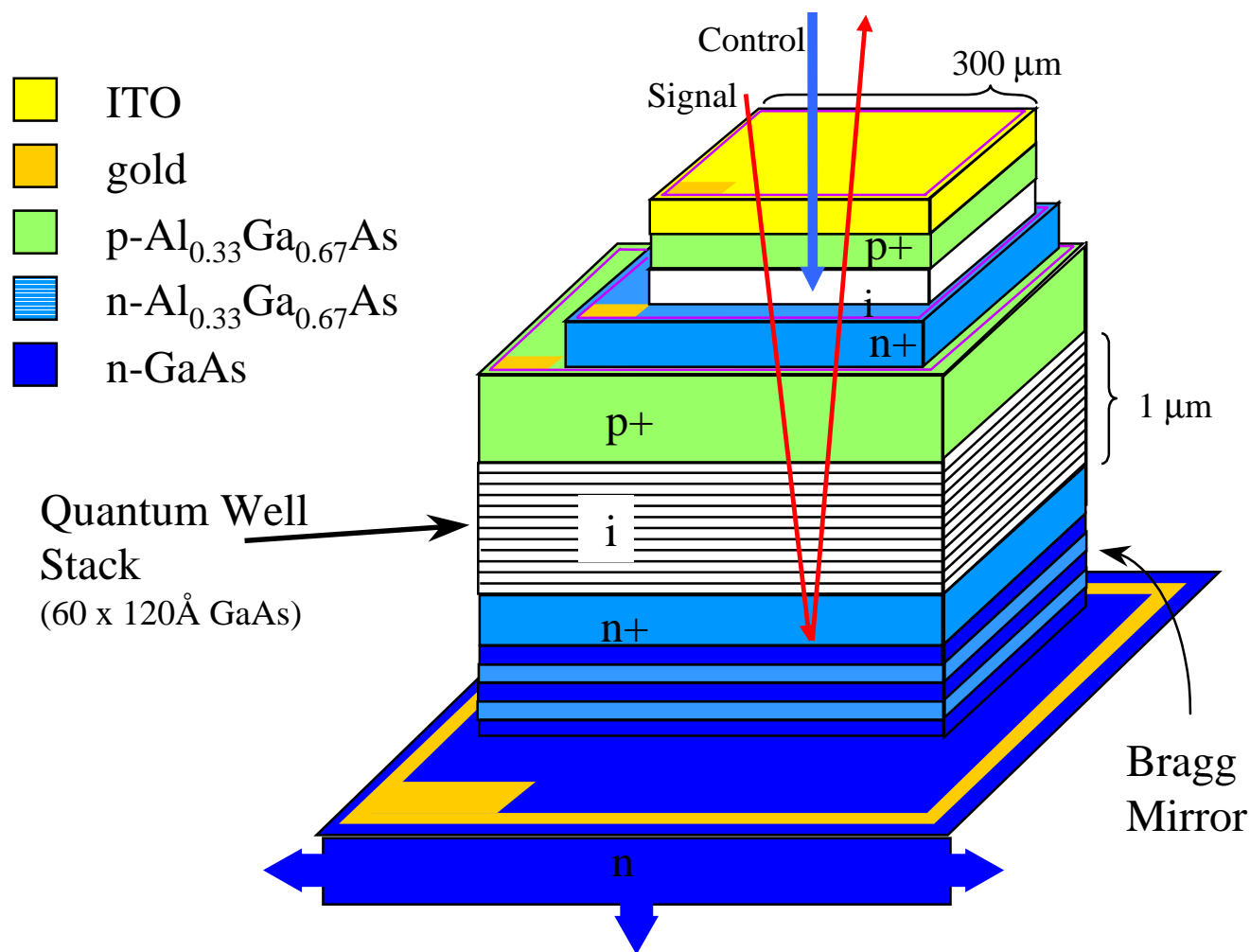
$$\frac{dV}{dt} = D \nabla_{xy}^2 V$$

$$D = \frac{1}{R_{SQ} C_A}$$

$R_{SQ}$  = Resistance per square

$C_A$  = Capacitance per unit area

# Device Structure

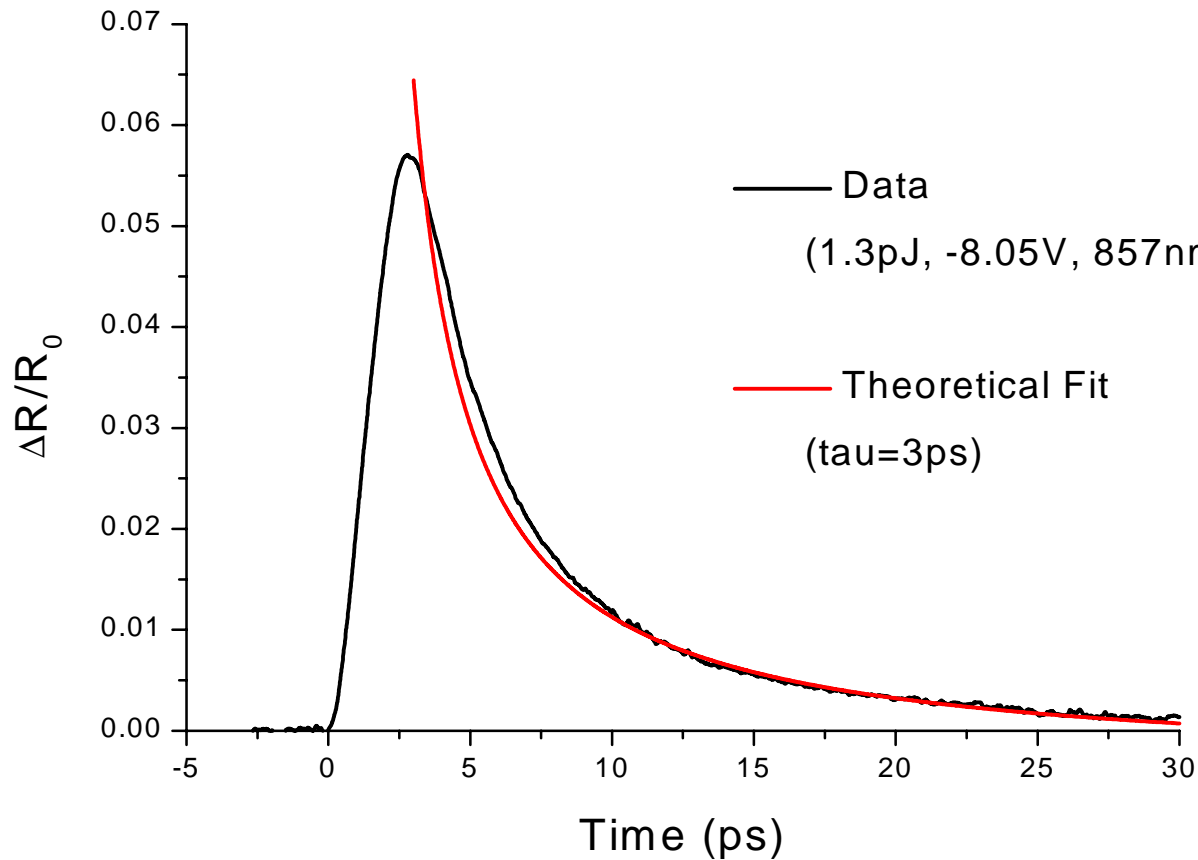


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# Results

## Change in Relative Reflectivity



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# Results: Large Signal Response

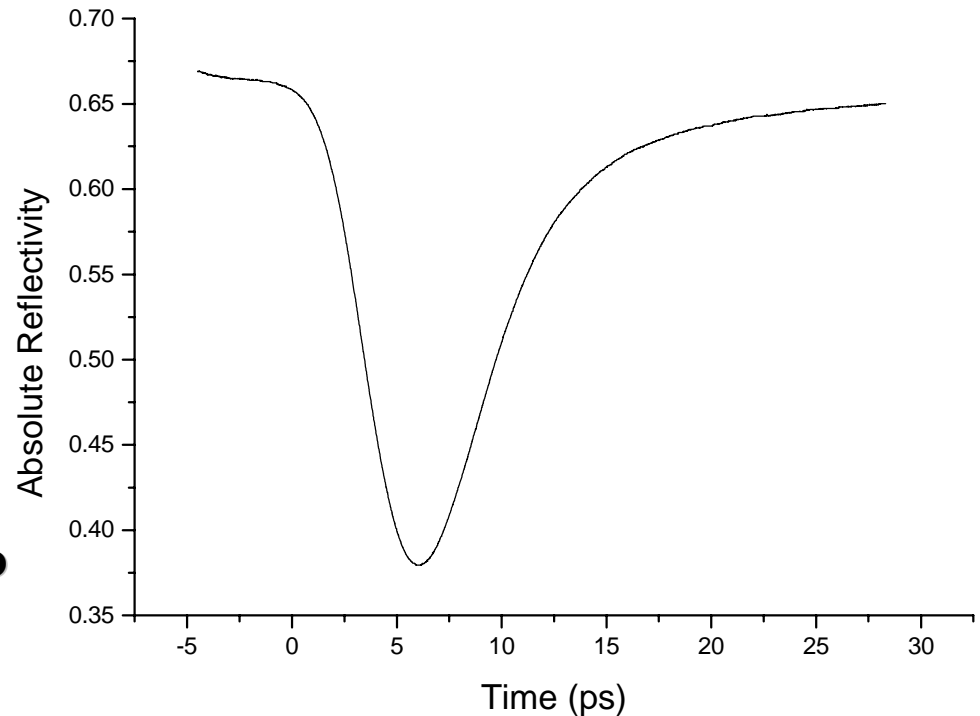
## Description:

- 3.5 $\mu\text{m}$  spot radius
- 1.5 pJ/pulse
- 39 fJ/ $\mu\text{m}^2$
- 2 ps pulse width

**20 ps FW-10%M**

**30% Reflectivity Change**

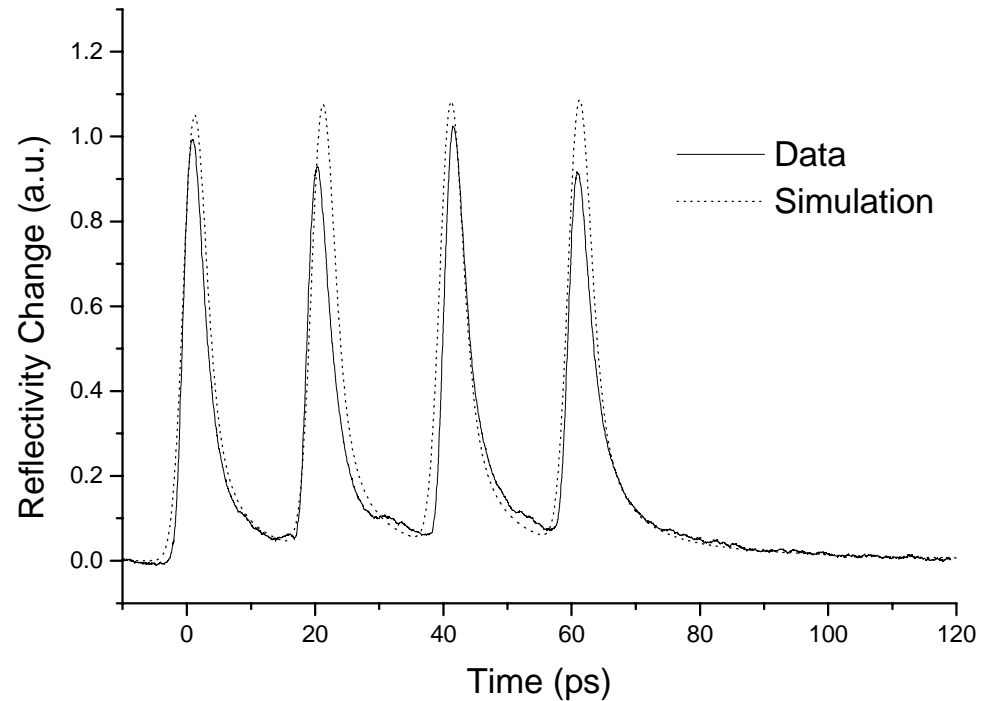
**Nearly 2-to-1 Contrast Ratio**



## Results: Pulse Repetition Response

### Description:

- 3.5  $\mu\text{m}$  spot radius
- 20 ps pulse separation
- 2 ps pulse length
- ~ 70 fJ/pulse



# ***Conclusions***

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**WDM interconnect between silicon chips successfully demonstrated**

**Synchronization of signals using short optical pulses**

**GaNAsN promising material for uniform long-wavelength devices, with cw VCSEL demonstrated**

**Ultrafast optically controlled optical gate may allow fast, digital, electrically-controllable wavelength converting and switching devices**